MOSFET – Power, Single, N-Channel, SO-8 FL 30 V, 93 A

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

• CPU Power Delivery, DC-DC Converters

MAXIMUM RATINGS ($T_J = 25^{\circ}C$ unless otherwise stated)

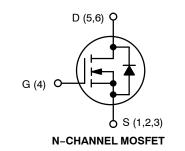
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Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V _{DSS}	30	V
Gate-to-Source Volt	ate-to-Source Voltage		V _{GS}	±20	V
Continuous Drain Current R _{e.IA}		$T_A = 25^{\circ}C$	Ι _D	21.8	A
(Note 1)		$T_A = 100^{\circ}C$	1	13.8	
Power Dissipation $R_{\theta JA}$ (Note 1)		$T_A = 25^{\circ}C$	PD	2.63	W
Continuous Drain Current R _{θ.IA} ≤		$T_A = 25^{\circ}C$	۱ _D	40	А
10 s (Note 1)		$T_A = 100^{\circ}C$		25	
Power Dissipation $R_{\theta,IA} \leq 10 \text{ s}$		$T_A = 25^{\circ}C$	PD	8.7	W
(Note 1)	Steady State				
Continuous Drain Current R _{θJA}	Oluic	$T_A = 25^{\circ}C$	۱ _D	13	А
(Note 2)		T _A = 100°C	1	8.2	
Power Dissipation $R_{\theta JA}$ (Note 2)		$T_A = 25^{\circ}C$	PD	0.93	W
Continuous Drain Current R _{θJC}		T _C = 25°C	۱ _D	93	А
(Note 1)		T _C = 85°C		59	
Power Dissipation $R_{\theta JC}$ (Note 1)		T _C = 25°C	PD	48	W
Pulsed Drain Current	$T_A = 25^{\circ}C$, $t_p = 10 \ \mu s$		I _{DM}	275	A
Current Limited by Package $T_A = 25^{\circ}C$			I _{Dmax}	100	А
Operating Junction and Storage Temperature		T _J , T _{STG}	–55 to +150	°C	
Source Current (Bod	Source Current (Body Diode)		۱ _S	44	А
Drain to Source DV/DT			dV/d _t	6	V/ns

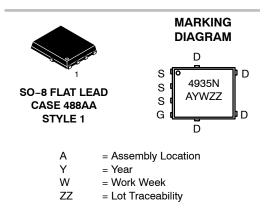


ON Semiconductor®

http://onsemi.com

V _{(BR)DSS}	V _{(BR)DSS} R _{DS(ON)} MAX	
30 V	$3.2~\mathrm{m}\Omega$ @ 10 V	00.4
30 V	4.2 mΩ @ 4.5 V	93 A





ORDERING INFORMATION

Device	Package	Shipping [†]		
NTMFS4935NT1G	SO-8 FL	1500 /		
NTMFS4935NCT1G	(Pb-Free)	Tape & Reel		
NTMFS4935NT3G	SO-8 FL	5000 /		
NTMFS4935NCT3G	(Pb-Free)	Tape & Reel		

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

MAXIMUM RATINGS ($T_J = 25^{\circ}C$ unless otherwise stated)

Parameter	Symbol	Value	Unit
Single Pulse Drain–to–Source Avalanche Energy T _J = 25°C, V _{DD} = 24 V, V _{GS} = 10 V, I _L = 47 A _{pk} , L = 0.1 mH, R _G = 25 Ω	E _{AS}	110	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)	ΤL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.
1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
2. Surface-mounted on FR4 board using the minimum recommended pad size.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ extsf{ heta}JC}$	2.6	
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	47.5	°C/W
Junction-to-Ambient - Steady State (Note 4)	$R_{\theta JA}$	134.8	°C/W
Junction-to-Ambient – (t \leq 10 s) (Note 3)	R_{\thetaJA}	14.4	

Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
 Surface-mounted on FR4 board using the minimum recommended pad size.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V_{GS} = 0 V, I_D = 250 μ A		30			V
Drain-to-Source Breakdown Voltage (transient)	V _{(BR)DSSt}	V _{GS} = 0 V, I _{D(aval)} T _{case} = 25°C, t _{transi}	= 19.5 A, _{ent} = 100 ns	34			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} / T _J				15		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 V,$	$T_J = 25^{\circ}C$			1.0	•
		V _{DS} = 24 V	T _J = 125°C			10	μA
Gate-to-Source Leakage Current	I _{GSS}	V_{DS} = 0 V, V_{GS}	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 250 \ \mu A$		1.2	1.63	2.2	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				4.0		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 30 A		2.7	3.2	
			I _D = 15 A		2.7		
		V _{GS} = 4.5 V	I _D = 30 A		3.7	4.2	mΩ
			I _D = 15 A		3.7		
Forward Transconductance	9 _{FS}	V _{DS} = 1.5 V, I _D = 15 A			32		S
CHARGES, CAPACITANCES & GATE RESIS	TANCE				-		
Input Capacitance	C _{ISS}				3579	4850	
Output Capacitance	C _{OSS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 15 V			1264	1710	pF
Reverse Transfer Capacitance	C _{RSS}				39	59	
Capacitance Ratio	C _{RSS} / C _{ISS}	V_{GS} = 0 V, f = 1 MHz, V_{DS} = 15 V			0.011	0.022	
Total Gate Charge	Q _{G(TOT)}				22		
Threshold Gate Charge	Q _{G(TH)}	V _{GS} = 4.5 V, V _{DS} = 15 V; I _D = 30 A			5.6		
Gate-to-Source Charge	Q _{GS}				10.2		nC

SWITCHING CHARACTERISTICS (Note 6)

Gate-to-Drain Charge

Total Gate Charge

Turn-On Delay Time	t _{d(ON)}		16.3	
Rise Time	t _r	V _{GS} = 4.5 V, V _{DS} = 15 V,	20	
Turn-Off Delay Time	t _{d(OFF)}	$I_{\rm D}$ = 15 A, R _G = 3.0 Ω	27.5	ns
Fall Time	t _f		6.6	

 V_{GS} = 10 V, V_{DS} = 15 V; I_{D} = 30 A

3.0

49.4

nC

 Q_{GD}

Q_{G(TOT)}

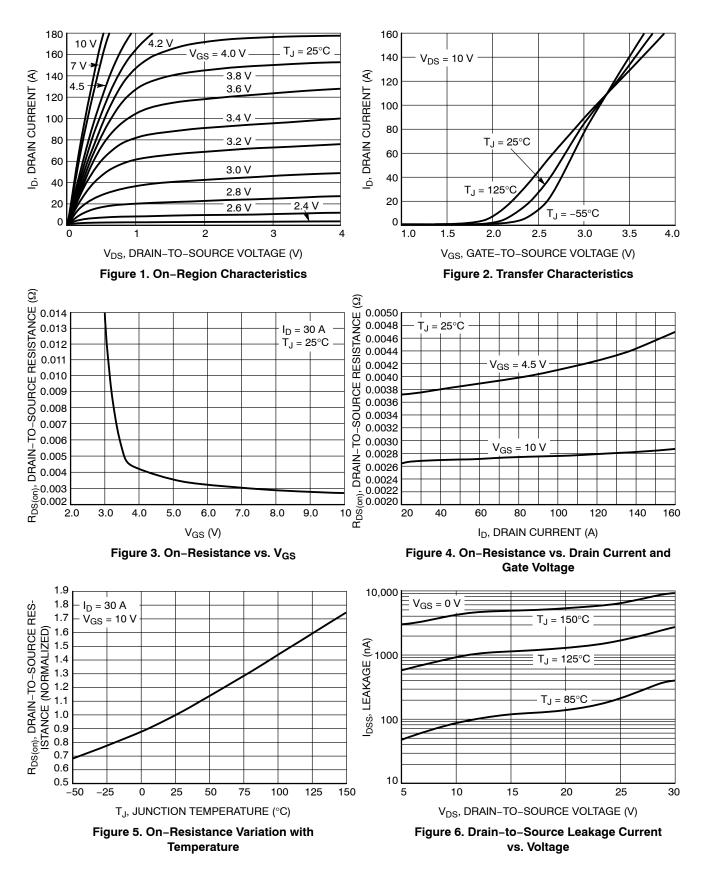
5. Pulse Test: pulse width \leq 300 µs, duty cycle \leq 2%. 6. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise specified)

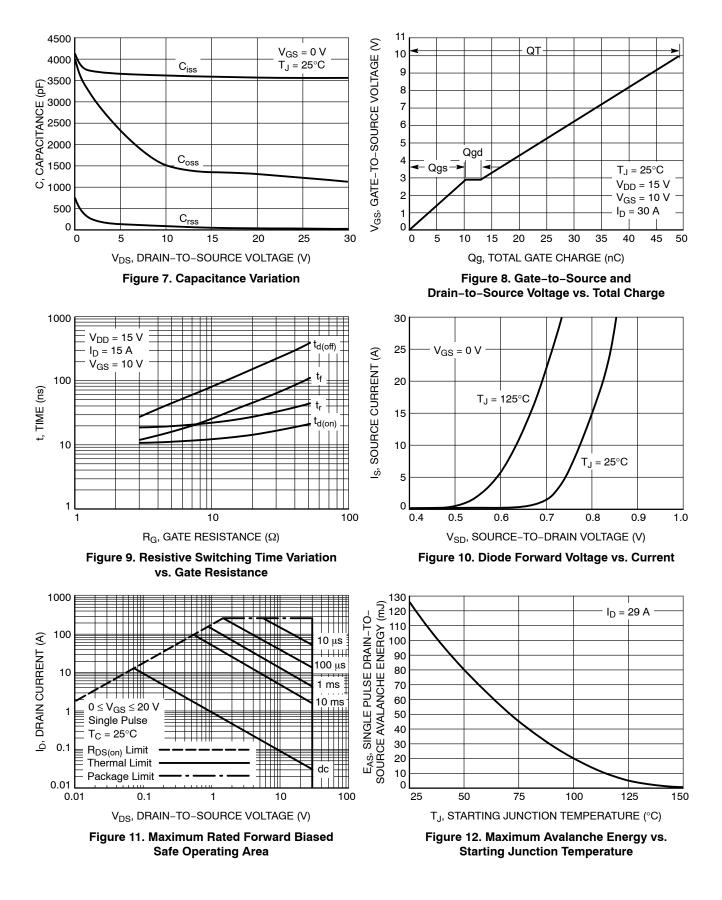
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS (N	ote 6)						
Turn-On Delay Time	t _{d(ON)}	V_{GS} = 10 V, V_{DS} = 15 V, I _D = 15 A, R _G = 3.0 Ω			11.2		ns
Rise Time	t _r				18.7		
Turn-Off Delay Time	t _{d(OFF)}				28.3		
Fall Time	t _f				12.1		
DRAIN-SOURCE DIODE CHARACT	ERISTICS						
Forward Diode Voltage	V _{SD}	$V_{GS} = 0 V, I_{S} = 30 A T_{J} = 25^{\circ}C T_{J} = 125^{\circ}C$		0.85	1.1	v	
				0.72			
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, dIS/dt = 100 A/µs, I _S = 30 A			44.4		ns
Charge Time	t _a				21.6		
Discharge Time	t _b				22.8		
Reverse Recovery Charge	Q _{RR}				45		nC
PACKAGE PARASITIC VALUES				-	-		
Source Inductance	L _S	T _A = 25°C			0.65		nH
Drain Inductance	L _D				0.005		nH
Gate Inductance	L _G				1.84		nH
Gate Resistance	R _G				1.1	1.4	Ω

5. Pulse Test: pulse width \leq 300 µs, duty cycle \leq 2%. 6. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS



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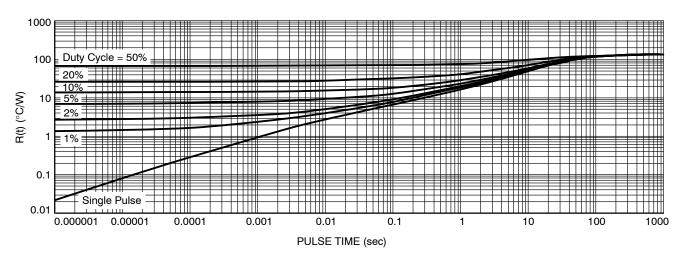
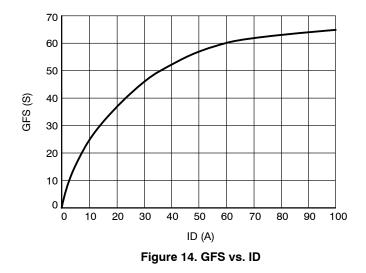
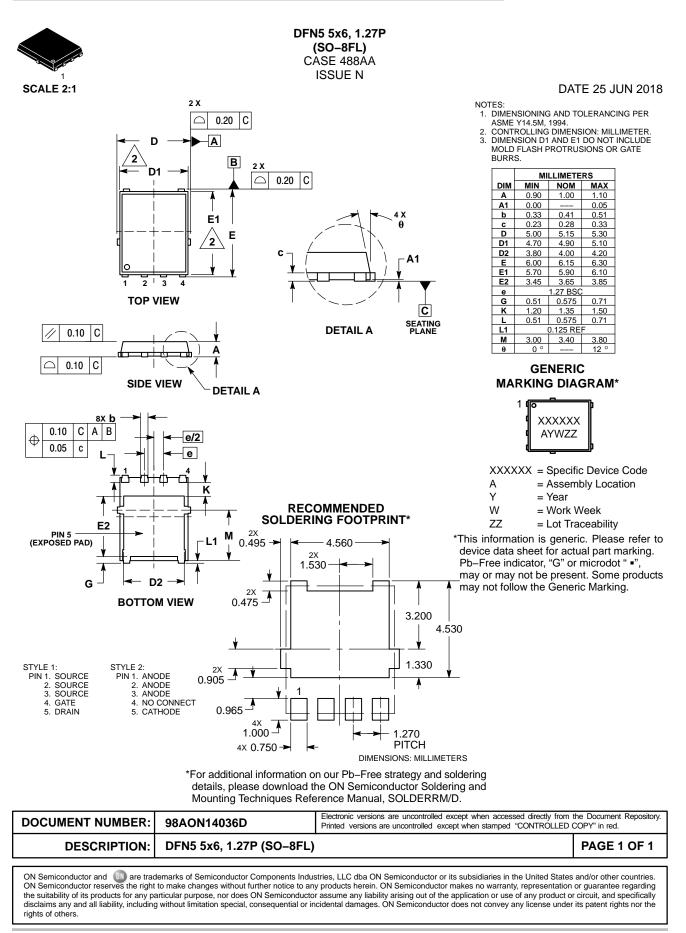


Figure 13. Thermal Response







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